


<b>Search Notes</b> 	<b>Application/Control No.</b> 10673698	<b>Applicant(s)/Patent Under Reexamination</b> LEE ET AL.
	<b>Examiner</b> Pich, Ponnoreay	<b>Art Unit</b> 2135

SEARCHED			
Class	Subclass	Date	Examiner
380	270,34	2/24/09	2/24/09

SEARCH NOTES		
Search Notes	Date	Examiner
380/255,259,270,33-34,277; 709/223-225; 726/2-6; and 713/150 (Limited by text on EAST) and text search on EAST, see notes	2/24/09	PP
Double patenting search by inventor name on PALM	2/23/09	PP
google.com, see notes	2/24/09	PP

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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